

September

FDMS039N08B

N-Channel PowerTrench[®] MOSFET 80V, 100A, 3.9m Ω

Features

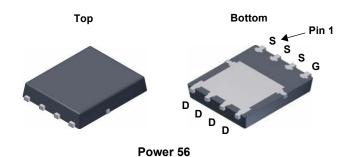
- $R_{DS(on)}$ = 3.2m Ω (Typ.)@ V_{GS} = 10V, I_D = 50A
- Low FOM R_{DS(on)} *Q_G
- · Low reverse recovery charge, Q_{rr}
- · Soft reverse recovery body diode
- Enables highly efficiency in synchronous rectification
- · Fast Switching Speed
- · 100% UIL Tested
- · RoHS Compliant

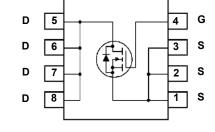
Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

- Synchronous Rectification for Server / Telecom PSU
- · Battery Charger and Battery Protection circuit
- · DC motor drives and Uninterruptible Power Supplies
- · Micro Solar Inverter





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol	Parameter			Ratings	Units
V _{DSS}	Drain to Source Voltage			80	V
V _{GSS}	Gate to Source Voltage			±20	V
Danier Commont		- Continuous (T _C = 25°C)		100	۸
Drain Current	Drain Current	- Continuous (T _A = 25°C)	(Note 1)	19.4	Α
I _{DM}	Drain Current	- Pulsed	(Note 2)	400	Α
E _{AS}	Single Pulsed Avalanche Energy	•	(Note 3)	240	mJ
D	Dower Dissinction	$(T_C = 25^{\circ}C)$		104	W
P _D Power Dissipation		$(T_A = 25^{\circ}C)$	(Note 1)	2.5	W
T _J , T _{STG}	Operating and Storage Temperatu	ıre Range		-55 to +150	°C

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note	1) 50	- C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS039N08B	FDMS039N08B	Power 56	13 "	12 mm	3000 units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	80	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.04	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64V, V _{GS} = 0V	-	-	1	μА
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	-	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 50A$	-	3.2	3.9	mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_D = 50A$ (Note 4)	-	100	-	S

Dynamic Characteristics

•						
C _{iss}	Input Capacitance	V 40V V 0V	-	5715	7600	pF
C _{oss}	Output Capacitance	$V_{DS} = 40V, V_{GS} = 0V$ f = 1MHz		881	1170	pF
C _{rss}	Reverse Transfer Capacitance			15	-	pF
C _{oss} (er)	Engry Releted Output Capacitance	V _{DS} = 40V, V _{GS} = 0V	-	1646	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	$V_{DS} = 40V, I_{D} = 50A$	-	77	100	nC
Q _{gs}	Gate to Source Gate Charge	V _{GS} = 0V to 10V	-	34	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau		-	13	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	(Note 4,5	-	16	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	42	94	ns
t _r	Turn-On Rise Time	$V_{DD} = 40V, I_{D} = 50A$	-	25	60	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10V, R_{GEN} = 4.7 Ω	-	48	106	ns
t _f	Turn-Off Fall Time	(Note 4,5)	-	17	44	ns
ESR	Equivalent Series Resistance	Drain Open, f = 1MHZ	-	1.2	-	Ω

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	100	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	400	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 50A	-	-	1.3	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 50A, V _{DD} = 40V	-	68	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note 4)	-	80	-	nC

^{1.78} p_{JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 0.3mH, I_{AS} = 40A, Starting T_J = 25°C
- 4. Pulse Test: Pulse Width $\leq 300~\mu\text{s},$ Duty cycle $\leq 2.0\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

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Typical Performance Characteristics

Figure 1. On-Region Characteristics

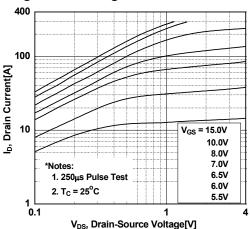


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

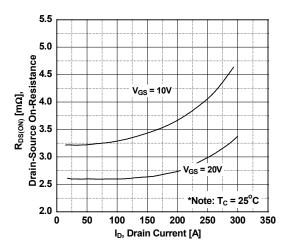


Figure 5. Capacitance Characteristics

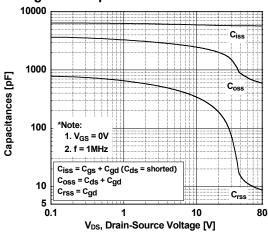


Figure 2. Transfer Characteristics

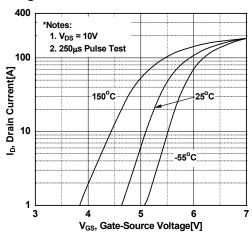


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

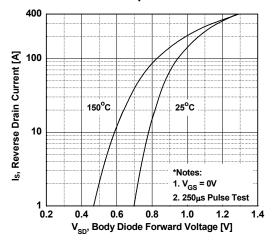
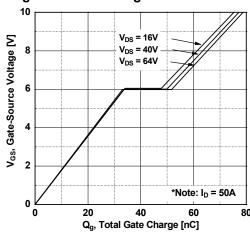


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

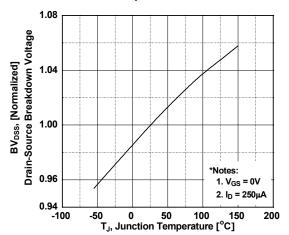


Figure 9. Maximum Safe Operating Area vs. Ambient Temperature

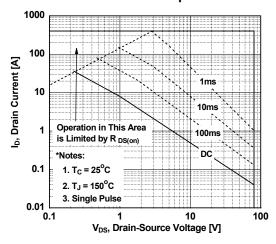


Figure 11. Unclamped Inductive Switching Capability

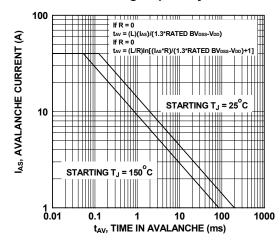


Figure 8. On-Resistance Variation vs. Temperature

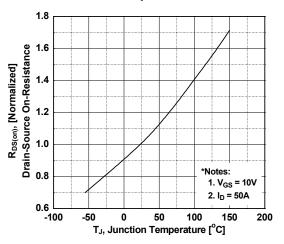


Figure 10. Maximum Drain Current

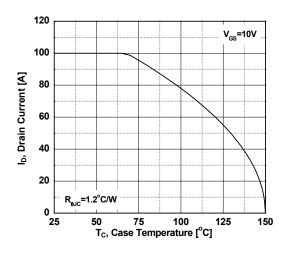
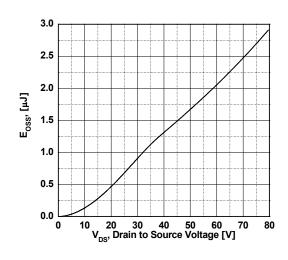
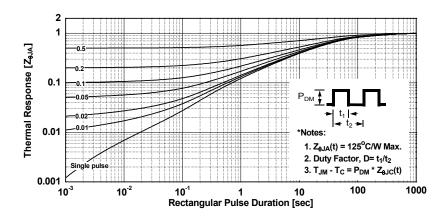


Figure 12. Eoss vs. Drain to Source Voltage

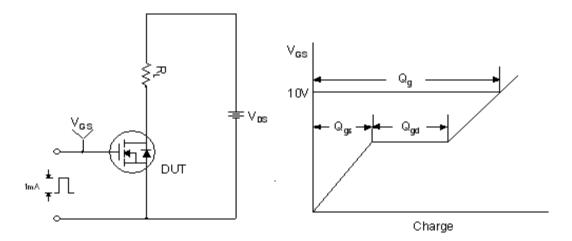


Typical Performance Characteristics (Continued)

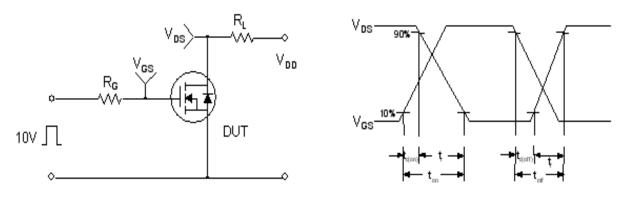




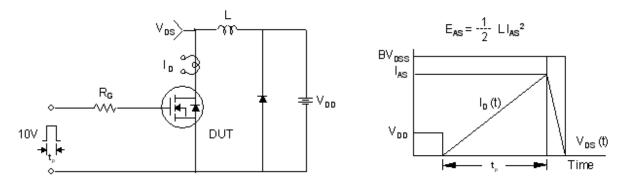
Gate Charge Test Circuit & Waveform



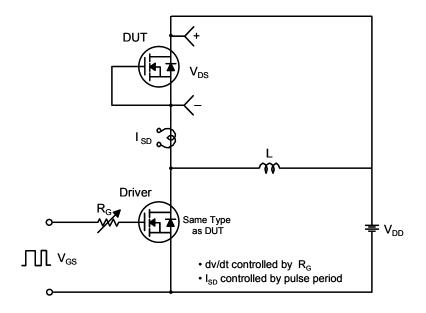
Resistive Switching Test Circuit & Waveforms

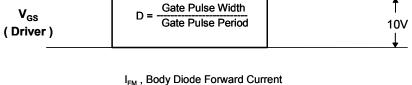


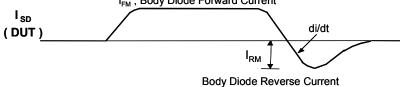
Unclamped Inductive Switching Test Circuit & Waveforms

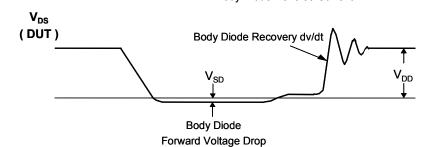


Peak Diode Recovery dv/dt Test Circuit & Waveforms

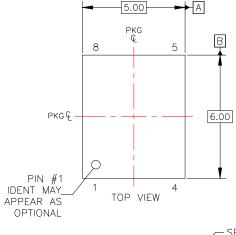


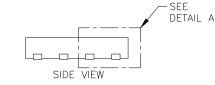




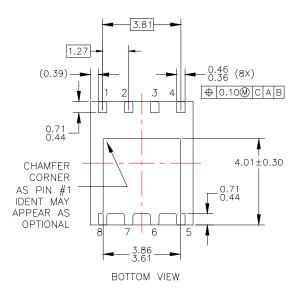


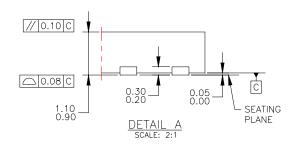
Dimensional Outline and Pad Layout

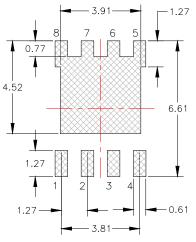




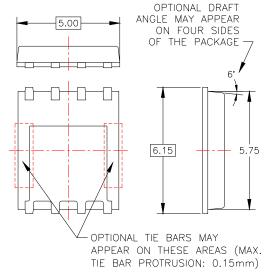












NOTES: UNLESS OTHERWISE SPECIFIED

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